Search Notes



10539211

Applicant(s)/Patent Under Reexamination

WANG ET AL.

Examiner

Art Unit

Hevey, John A

1709

SEARCHED

| Class | Subclass | Date | Examiner | |
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| 252 | 62 | 7/19/2007 | JAH | |
| 524 | 413 | 7/19/2007 | JAH | |

| SEARCH NOTES | | | | |
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| Search Notes | Date | Examiner | | |
| East - see search history | | | | |
| Inventor search in PALM | | | | |

| INTERFERENCE SEARCH | | | | |
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